



YOUSHANG SEMICONDUCTOR

**设计研发新型功率器件**

**各类小信号开关**

**中低压及高压大电流等场效应管**

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## Product Summary

$V_{(BR)DSS}$	$R_{DS(ON) Max}$	$I_D$ $T_A = +25^{\circ}C$
20V	55mΩ @ $V_{GS} = 4.5V$	4.6A
	100mΩ @ $V_{GS} = 2.5V$	3.4A

## Description

This new generation MOSFET is designed to minimize the on-state resistance ( $R_{DS(ON)}$ ) and yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

## Applications

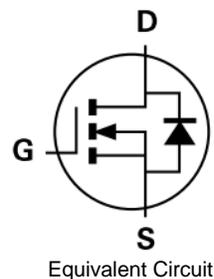
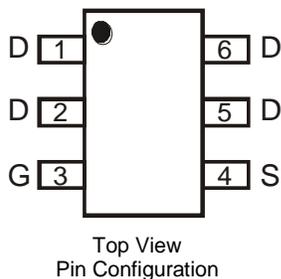
- DC-DC Converters
- Power Management Functions
- Backlighting

## Features and Benefits

- Low Input Capacitance
- Low On-Resistance
- Fast Switching Speed

## Mechanical Data

- Case: SOT26
- Case Material: Molded Plastic, "Green" Molding Compound; UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish – Tin Finish Annealed over Copper Leadframe; Solderable per MIL-STD-202, Method 208  $\text{E3}$
- Weight: 0.018 grams (Approximate)



**Maximum Ratings** (@ $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

Characteristic		Symbol	Value	Unit	
Drain-Source Voltage		$V_{DSS}$	20	V	
Gate-Source Voltage		$V_{GSS}$	$\pm 12$	V	
Continuous Drain Current, $V_{GS} = 10\text{V}$	Steady State	$I_D$	$T_A = +25^\circ\text{C}$ (Note 6)	4.6	A
			$T_A = +70^\circ\text{C}$ (Note 6)	3.7	
			$T_A = +25^\circ\text{C}$ (Note 5)	3.7	
Maximum Body Diode Forward Current (Note 6)		$I_S$	2.7	A	
Pulsed Drain Current (Note 7)		$I_{DM}$	16	A	
Pulsed Source Current (Note 7)		$I_{SM}$	16	A	

**Thermal Characteristics** (@ $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

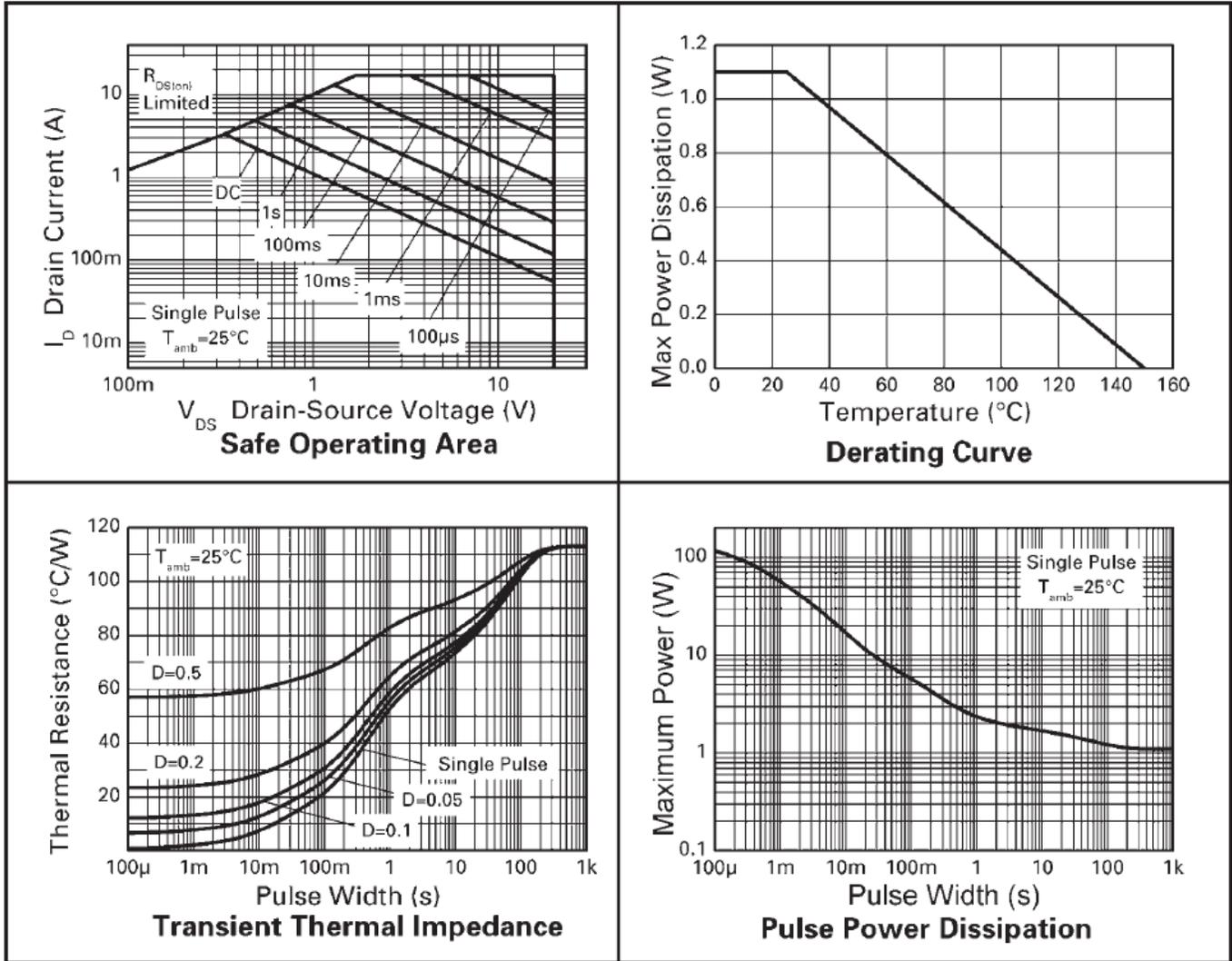
Characteristic		Symbol	Value	Unit
Total Power Dissipation	$T_A = +25^\circ\text{C}$ (Note 5)	$P_D$	1.1	W
Linear Derating Factor			8.8	$\text{mW}/^\circ\text{C}$
Total Power Dissipation	$T_A = +25^\circ\text{C}$ (Note 6)	$P_D$	1.7	W
Linear Derating Factor			13.6	$\text{mW}/^\circ\text{C}$
Thermal Resistance, Junction to Ambient	Steady State (Note 5)	$R_{\theta JA}$	113	$^\circ\text{C}/\text{W}$
	Steady State (Note 6)		70	$^\circ\text{C}/\text{W}$
Operating and Storage Temperature Range		$T_J, T_{STG}$	-55 to +150	$^\circ\text{C}$

**Electrical Characteristics** (@ $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

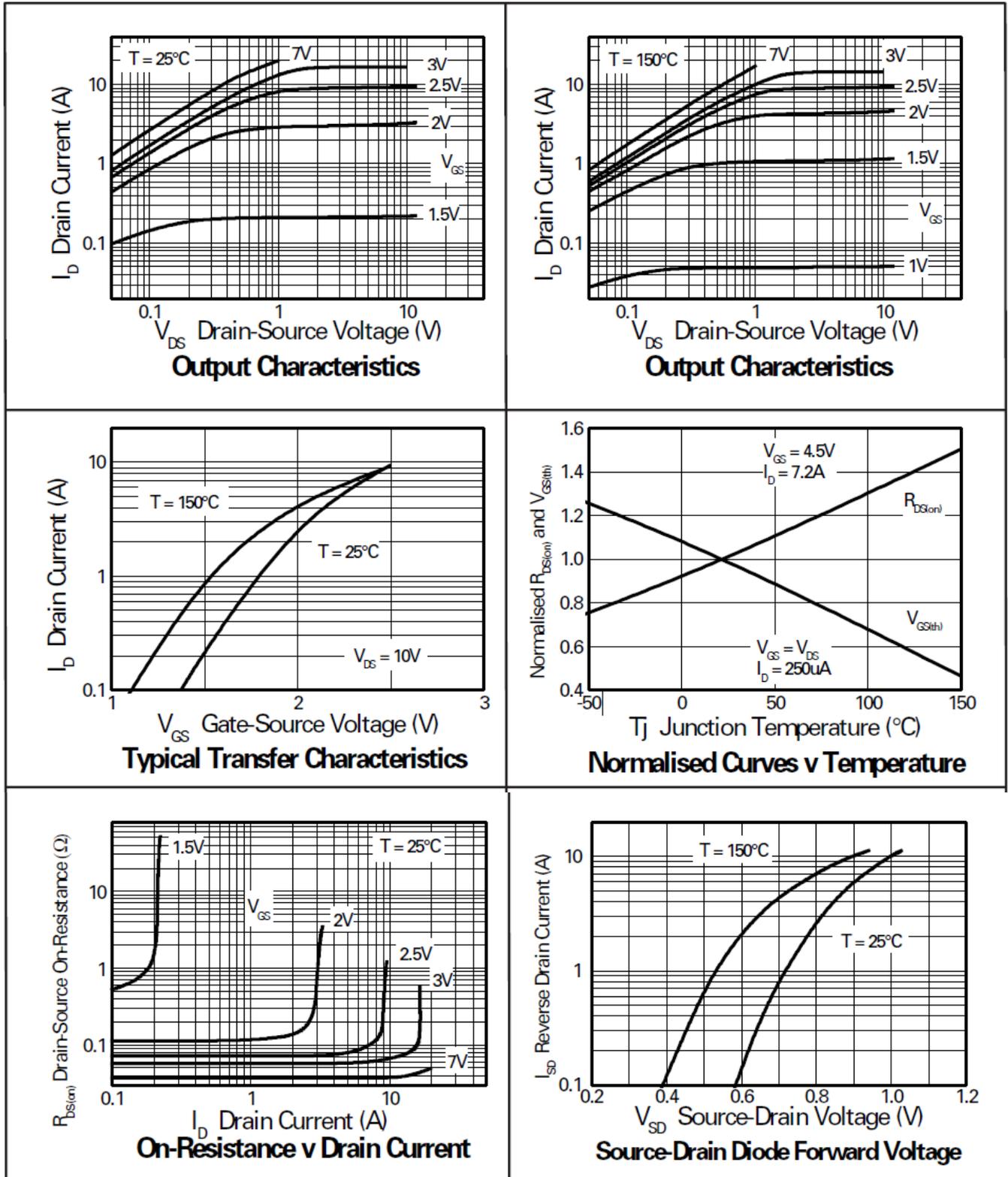
Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
<b>OFF CHARACTERISTICS (Note 9)</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	20	—	—	V	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$
Zero Gate Voltage Drain Current	$I_{DSS}$	—	—	1	$\mu\text{A}$	$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}$
Gate-Source Leakage	$I_{GSS}$	—	—	$\pm 100$	nA	$V_{GS} = \pm 12\text{V}, V_{DS} = 0\text{V}$
<b>ON CHARACTERISTICS (Note 9)</b>						
Gate Threshold Voltage	$V_{GS(TH)}$	0.7	—	—	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
Static Drain-Source On-Resistance (Note 8)	$R_{DS(ON)}$	—	—	55	m $\Omega$	$V_{GS} = 4.5\text{V}, I_D = 7.2\text{A}$
		—	—	100		$V_{GS} = 2.5\text{V}, I_D = 4.6\text{A}$
Diode Forward Voltage (Note 8)	$V_{SD}$	—	0.85	0.95	V	$V_{GS} = 0\text{V}, I_S = 4.1\text{A}$
Forward Transconductance (Notes 8 & 10)	$g_{fs}$	—	13	—	S	$V_{DS} = 10\text{V}, I_D = 7.2\text{A}$
<b>DYNAMIC CHARACTERISTICS (Note 10)</b>						
Input Capacitance	$C_{iss}$	—	837	—	pF	$V_{DS} = 10\text{V}, V_{GS} = 0\text{V}$ $f = 1.0\text{MHz}$
Output Capacitance	$C_{oss}$	—	168	—		
Reverse Transfer Capacitance	$C_{rss}$	—	90	—		
Total Gate Charge	$Q_g$	—	8.2	—	nC	$V_{DS} = 10\text{V}, I_D = 7.2\text{A}, V_{GS} = 4.5\text{V}$
Gate-Source Charge	$Q_{gs}$	—	2.3	—		
Gate-Drain Charge	$Q_{gd}$	—	2.0	—		
Turn-On Delay Time	$t_{D(ON)}$	—	4.7	—	ns	$V_{GS} = 4.5\text{V}, V_{DD} = 10\text{V}, R_G = 6.0\Omega,$ $I_D = 1.0\text{A}$
Turn-On Rise Time	$t_R$	—	5.7	—		
Turn-Off Delay Time	$t_{D(OFF)}$	—	18.5	—		
Turn-Off Fall Time	$t_F$	—	10.5	—		
Body Diode Reverse Recovery Time	$t_{RR}$	—	12	—	ns	$I_F = 1.9\text{A}, dI/dt = 100\text{A}/\mu\text{s}$
Body Diode Reverse Recovery Charge	$Q_{RR}$	—	4.9	—	nC	

- Notes:
- For a device surface mounted on 25mm x 25mm FR-4 PCB with high coverage of single sided 1oz copper, in still air conditions.
  - For a device surface mounted on FR-4 PCB measured at  $t \leq 5$  secs.
  - Repetitive rating 25mm x 25mm FR-4 PCB,  $D = 0.05$ , pulse width 10 $\mu\text{s}$  - pulse width limited by maximum junction temperature. Refer to Transient Thermal Impedance graph.
  - Measured under pulsed conditions. Width=300 $\mu\text{s}$ . Duty cycle  $\leq 2\%$ .
  - Short duration pulse test used to minimize self-heating effect.
  - Guaranteed by design. Not subject to product testing.

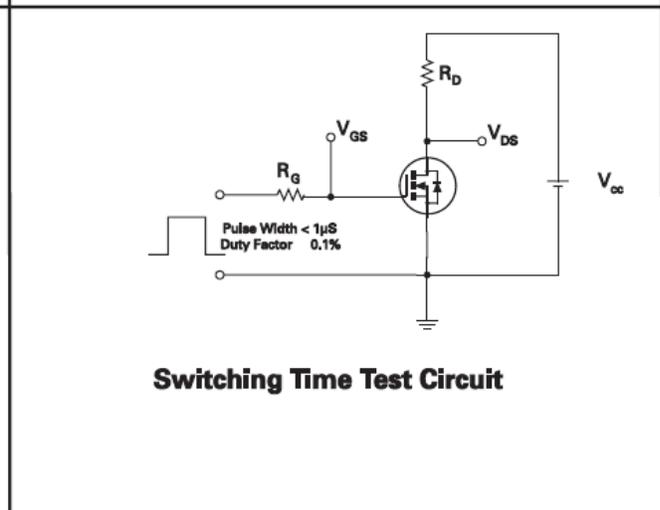
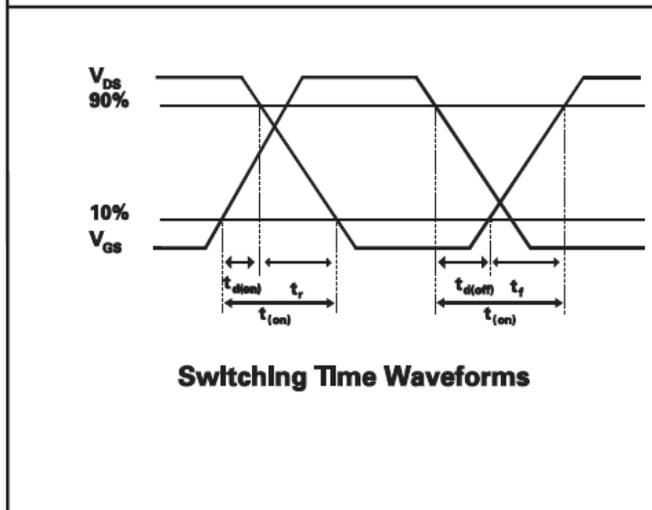
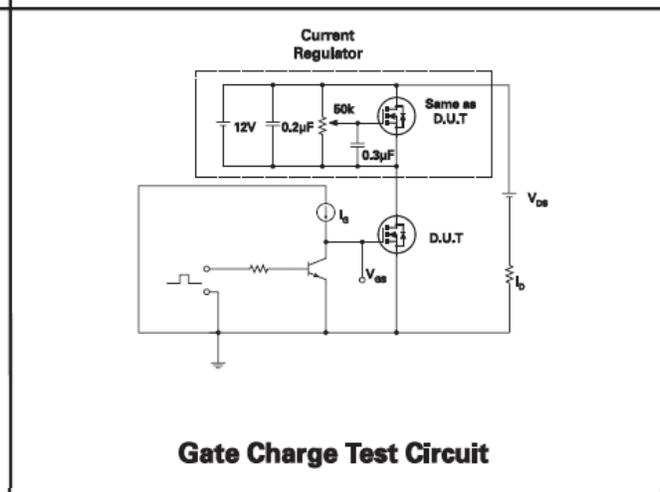
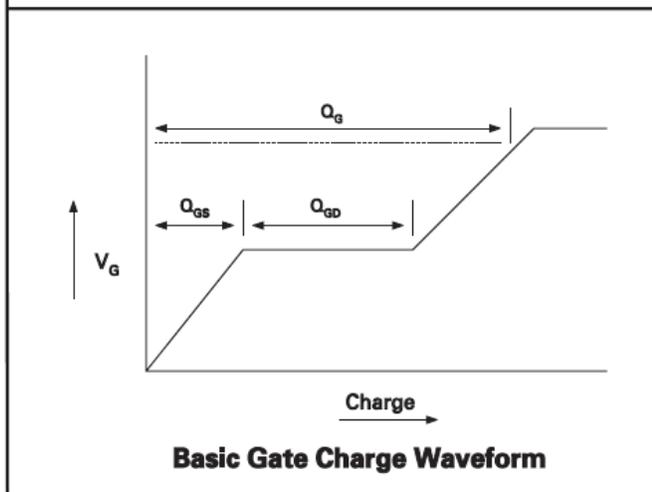
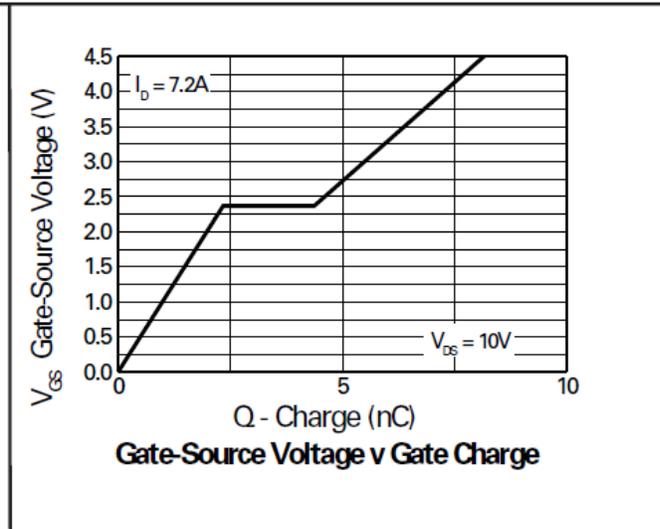
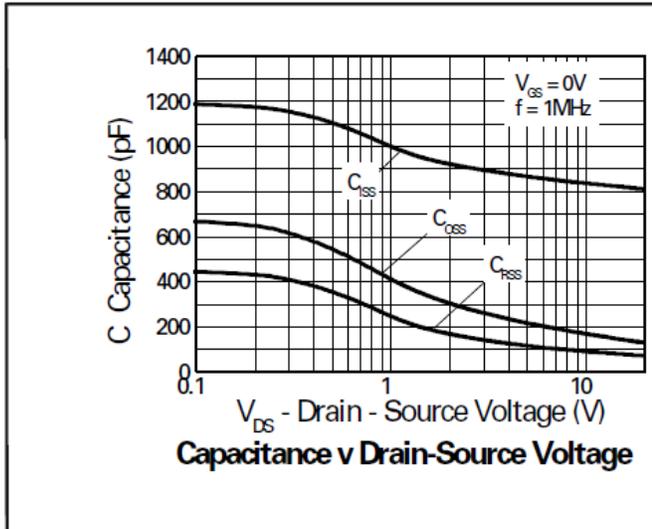
**TYPICAL CHARACTERISTICS**



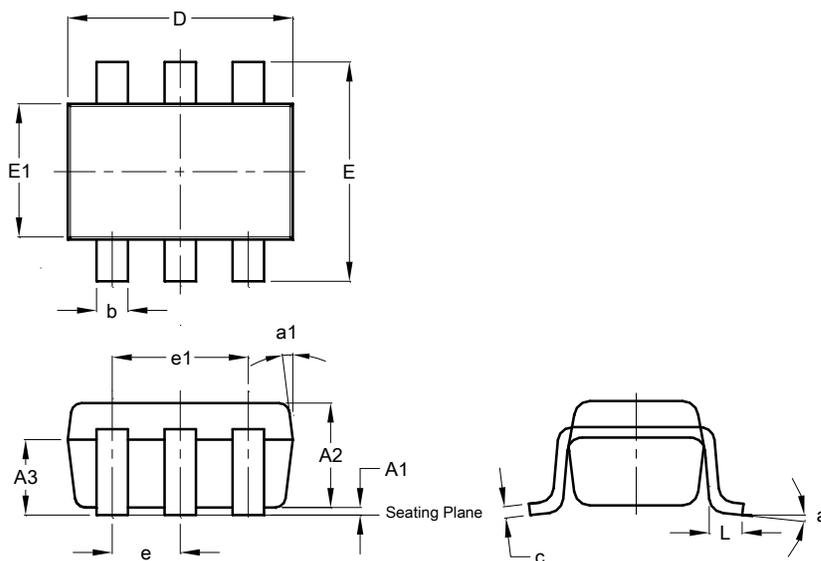
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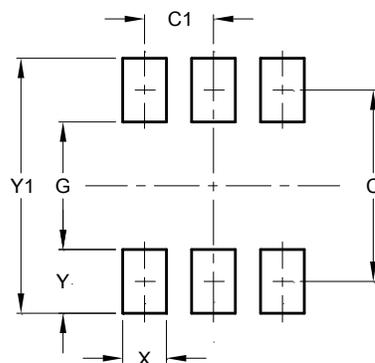


### Package Outline Dimensions



SOT26			
Dim	Min	Max	Typ
A1	0.013	0.10	0.05
A2	1.00	1.30	1.10
A3	0.70	0.80	0.75
b	0.35	0.50	0.38
c	0.10	0.20	0.15
D	2.90	3.10	3.00
e	-	-	0.95
e1	-	-	1.90
E	2.70	3.00	2.80
E1	1.50	1.70	1.60
L	0.35	0.55	0.40
a	-	-	8°
a1	-	-	7°
All Dimensions in mm			

### Suggested Pad Layout



Dimensions	Value (in mm)
C	2.40
C1	0.95
G	1.60
X	0.55
Y	0.80
Y1	3.20